

## REPETITIVE AVALANCHE AND $dv/dt$ RATED HEXFET<sup>®</sup> TRANSISTORS THRU-HOLE (TO-205AF)

## IRFF330 JANTX2N6800 JANTXV2N6800 REF:MIL-PRF-19500/557 400V, N-CHANNEL

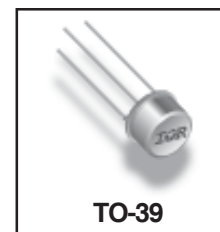
### Product Summary

Part Number	BVDSS	RDS(on)	ID
IRFF330	400V	1.0Ω	3.0A

The HEXFET<sup>®</sup> technology is the key to International Rectifier's advanced line of power MOSFET transistors. The efficient geometry and unique processing of this latest "State of the Art" design achieves: very low on-state resistance combined with high transconductance.

The HEXFET transistors also feature all of the well established advantages of MOSFETs such as voltage control, very fast switching, ease of paralleling and temperature stability of the electrical parameters.

They are well suited for applications such as switching power supplies, motor controls, inverters, choppers, audio amplifiers and high energy pulse circuits.



TO-39

### Features:

- Repetitive Avalanche Ratings
- Dynamic  $dv/dt$  Rating
- Hermetically Sealed
- Simple Drive Requirements
- Ease of Paralleling
- ESD Rating: Class 1C per MIL-STD-750, Method 1020

### Absolute Maximum Ratings

	Parameter		Units
$I_D$ @ $V_{GS} = 10V, T_C = 25^\circ C$	Continuous Drain Current	3.0	A
$I_D$ @ $V_{GS} = 10V, T_C = 100^\circ C$	Continuous Drain Current	2.0	
$I_{DM}$	Pulsed Drain Current <sup>①</sup>	12	
$P_D$ @ $T_C = 25^\circ C$	Max. Power Dissipation	25	W
	Linear Derating Factor	0.20	W/ $^\circ C$
$V_{GS}$	Gate-to-Source Voltage	$\pm 20$	V
EAS	Single Pulse Avalanche Energy <sup>②</sup>	191	mJ
IAR	Avalanche Current <sup>①</sup>	3.0	A
EAR	Repetitive Avalanche Energy <sup>①</sup>	2.5	mJ
$dv/dt$	Peak Diode Recovery $dv/dt$ <sup>③</sup>	4.0	V/ns
$T_J$	Operating Junction	-55 to 150	$^\circ C$
$T_{STG}$	Storage Temperature Range		
	Lead Temperature	300 (0.063 in. (1.6mm) from case for 10s)	
	Weight	0.98 (typical)	g

For footnotes refer to the last page

www.irf.com

**Electrical Characteristics @ T<sub>j</sub> = 25°C (Unless Otherwise Specified)**

	Parameter	Min	Typ	Max	Units	Test Conditions
BV <sub>DSS</sub>	Drain-to-Source Breakdown Voltage	400	—	—	V	V <sub>GS</sub> = 0V, I <sub>D</sub> = 1.0mA
ΔBV <sub>DSS</sub> /ΔT <sub>J</sub>	Temperature Coefficient of Breakdown Voltage	—	0.37	—	V/°C	Reference to 25°C, I <sub>D</sub> = 1.0mA
R <sub>DS(on)</sub>	Static Drain-to-Source On-State Resistance	—	—	1.0	Ω	V <sub>GS</sub> = 10V, I <sub>D</sub> = 2.0A ④
		—	—	1.15		V <sub>GS</sub> = 10V, I <sub>D</sub> = 3.0A ④
V <sub>GS(th)</sub>	Gate Threshold Voltage	2.0	—	4.0	V	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250μA
g <sub>fs</sub>	Forward Transconductance	2.0	—	—	S	V <sub>DS</sub> = 15V, I <sub>DS</sub> = 2.0A ④
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	—	—	25	μA	V <sub>DS</sub> = 320V, V <sub>GS</sub> = 0V
		—	—	250		V <sub>DS</sub> = 320V V <sub>GS</sub> = 0V, T <sub>J</sub> = 125°C
I <sub>GSS</sub>	Gate-to-Source Leakage Forward	—	—	100	nA	V <sub>GS</sub> = 20V
I <sub>GSS</sub>	Gate-to-Source Leakage Reverse	—	—	-100		V <sub>GS</sub> = -20V
Q <sub>g</sub>	Total Gate Charge	19.1	—	33	nC	V <sub>GS</sub> = 10V, I <sub>D</sub> = 3.0A
Q <sub>gs</sub>	Gate-to-Source Charge	1.0	—	5.8		V <sub>DS</sub> = 200V
Q <sub>gd</sub>	Gate-to-Drain ('Miller') Charge	6.7	—	19.9		
t <sub>d(on)</sub>	Turn-On Delay Time	—	—	30	ns	V <sub>DD</sub> = 200V, I <sub>D</sub> = 3.0A, V <sub>GS</sub> = 10V, R <sub>G</sub> = 7.5Ω
t <sub>r</sub>	Rise Time	—	—	35		
t <sub>d(off)</sub>	Turn-Off Delay Time	—	—	55		
t <sub>f</sub>	Fall Time	—	—	35		
L <sub>S</sub> + L <sub>D</sub>	Total Inductance	—	7.0	—	nH	Measured from drain lead (6mm/0.25in. from package) to source lead (6mm/0.25in. from package)
C <sub>iss</sub>	Input Capacitance	—	620	—	pF	V <sub>GS</sub> = 0V, V <sub>DS</sub> = 25V f = 1.0MHz
C <sub>oss</sub>	Output Capacitance	—	200	—		
C <sub>rss</sub>	Reverse Transfer Capacitance	—	75	—		

**Source-Drain Diode Ratings and Characteristics**

	Parameter	Min	Typ	Max	Units	Test Conditions
I <sub>S</sub>	Continuous Source Current (Body Diode)	—	—	3.0	A	
I <sub>SM</sub>	Pulse Source Current (Body Diode) ①	—	—	12		
V <sub>SD</sub>	Diode Forward Voltage	—	—	1.4	V	T <sub>j</sub> = 25°C, I <sub>S</sub> = 3.0A, V <sub>GS</sub> = 0V ④
t <sub>rr</sub>	Reverse Recovery Time	—	—	700	ns	T <sub>j</sub> = 25°C, I <sub>F</sub> = 3.0A, di/dt ≤ 100A/μs
Q <sub>RR</sub>	Reverse Recovery Charge	—	—	6.2	μC	V <sub>DD</sub> ≤ 50V ④
t <sub>on</sub>	Forward Turn-On Time	Intrinsic turn-on time is negligible. Turn-on speed is substantially controlled by L <sub>S</sub> + L <sub>D</sub> .				

**Thermal Resistance**

	Parameter	Min	Typ	Max	Units	Test Conditions
R <sub>thJC</sub>	Junction-to-Case	—	—	5.0	°C/W	Typical socket mount.
R <sub>thJA</sub>	Junction-to-Ambient	—	—	175		

Note: Corresponding Spice and Saber models are available on International Rectifier website.

For footnotes refer to the last page

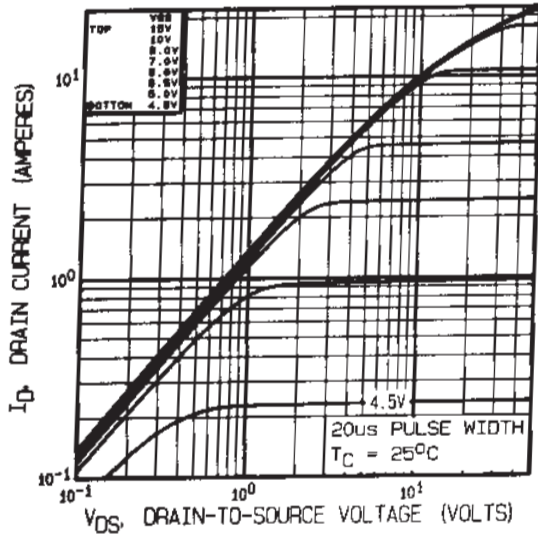


Fig1. Typical Output Characteristics

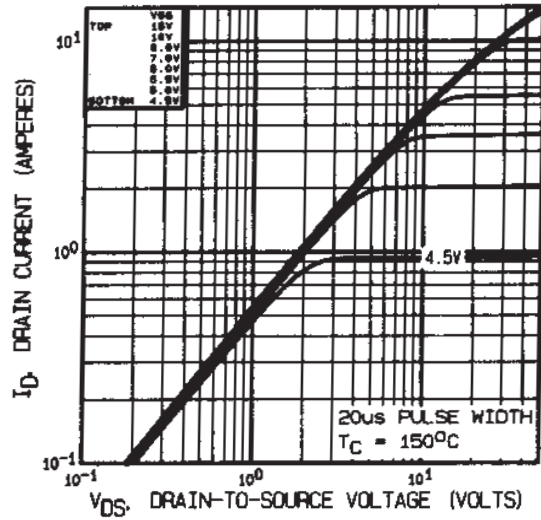


Fig2. Typical Output Characteristics

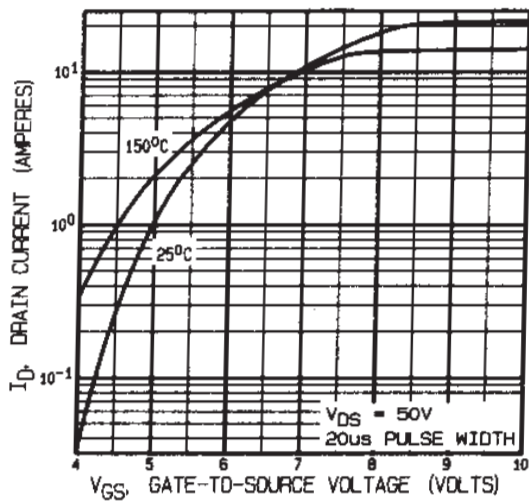


Fig3. Typical Transfer Characteristics

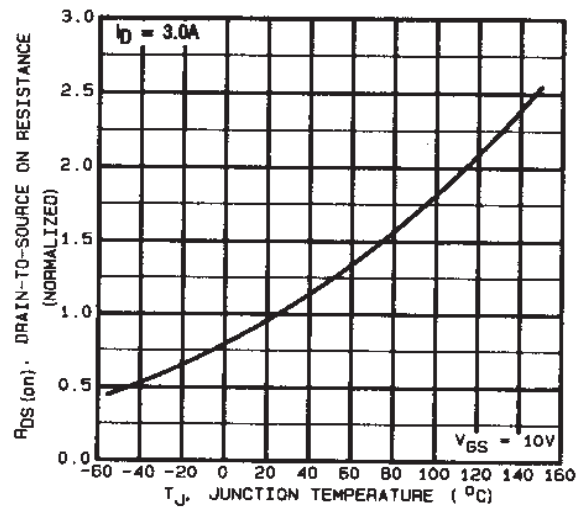


Fig4. Normalized On-Resistance Vs. Temperature

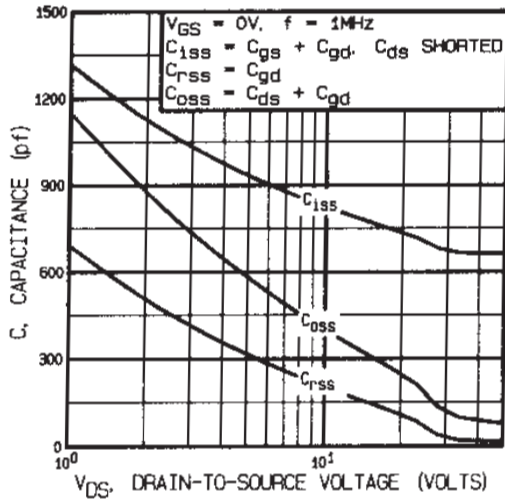


Fig5. Typical Capacitance Vs. Drain-to-Source Voltage

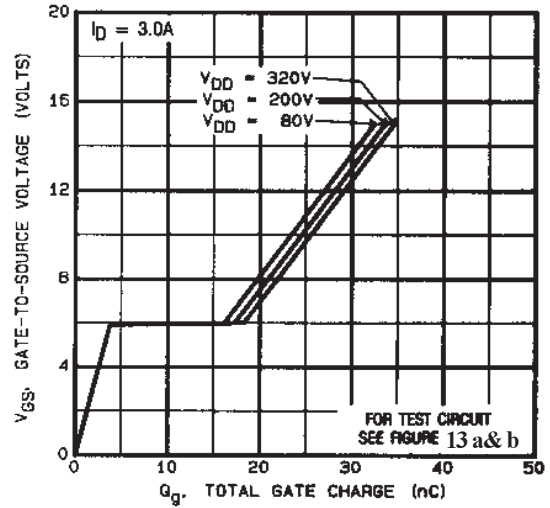


Fig6. Typical Gate Charge Vs. Gate-to-Source Voltage

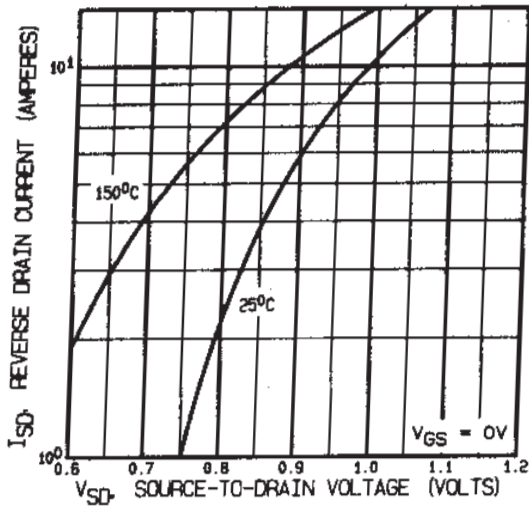


Fig7. Typical Source-Drain Diode Forward Voltage

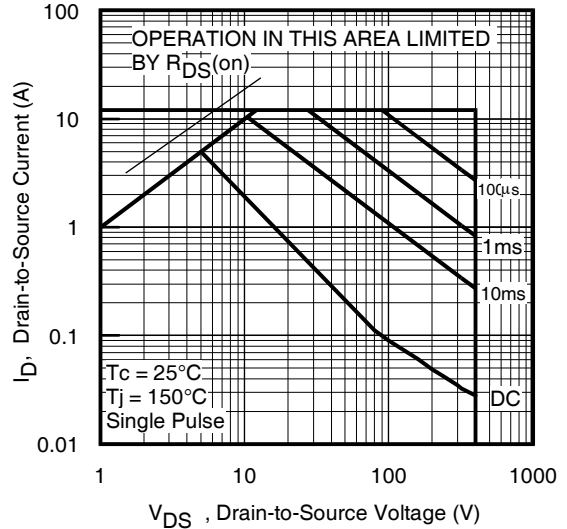


Fig8. Maximum Safe Operating Area

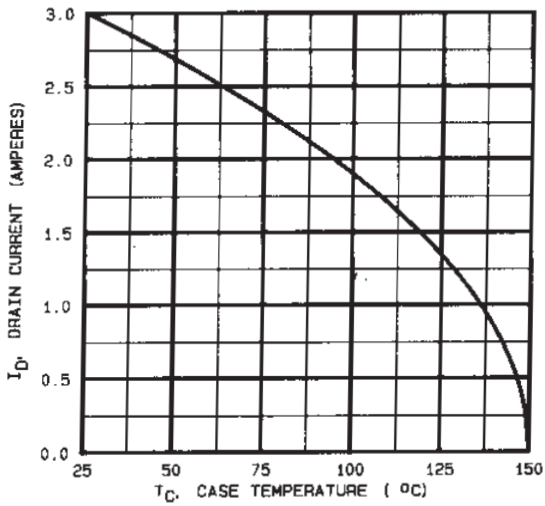


Fig 9. Maximum Drain Current Vs. Case Temperature

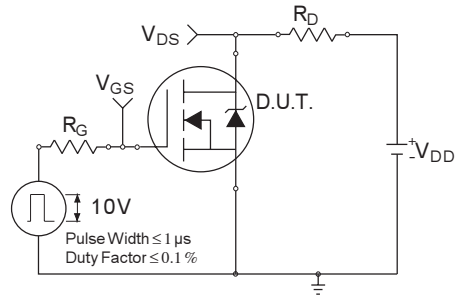


Fig 10a. Switching Time Test Circuit

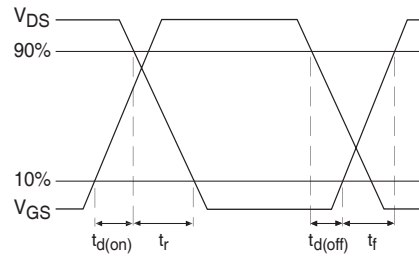


Fig 10b. Switching Time Waveforms

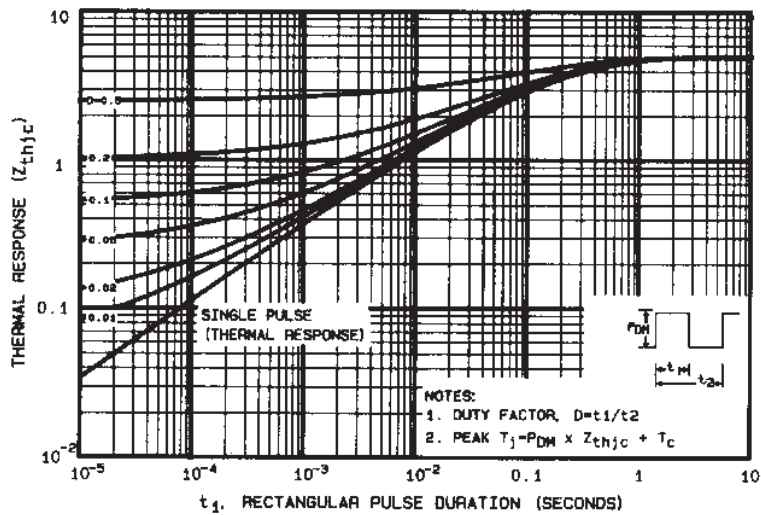


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

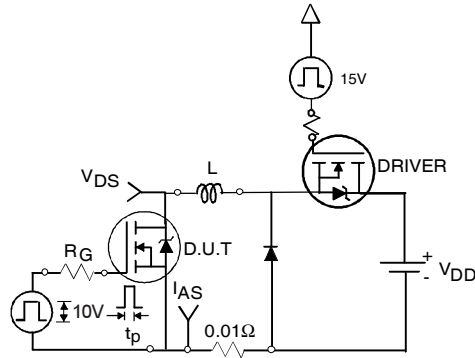


Fig 12a. Unclamped Inductive Test Circuit

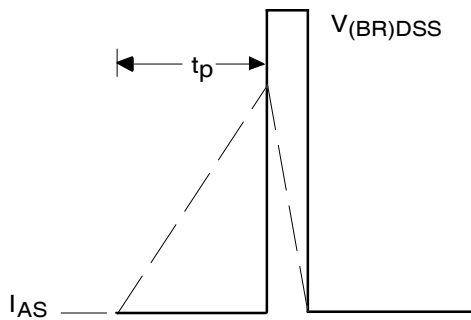


Fig 12b. Unclamped Inductive Waveforms

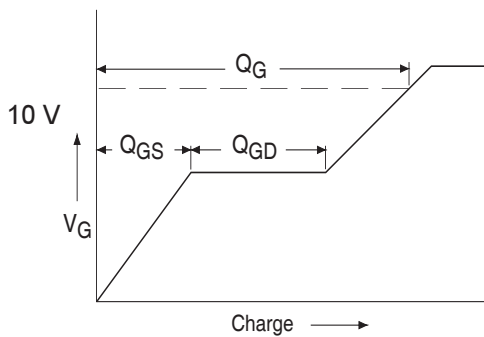


Fig 13a. Basic Gate Charge Waveform

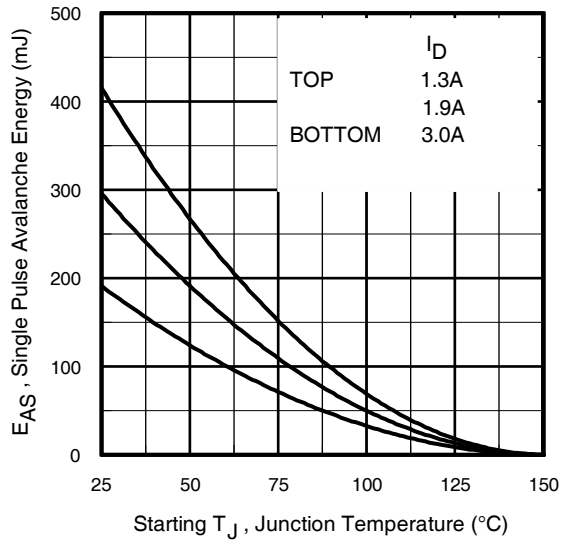


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

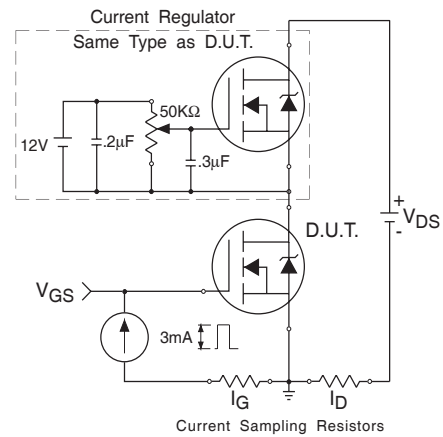
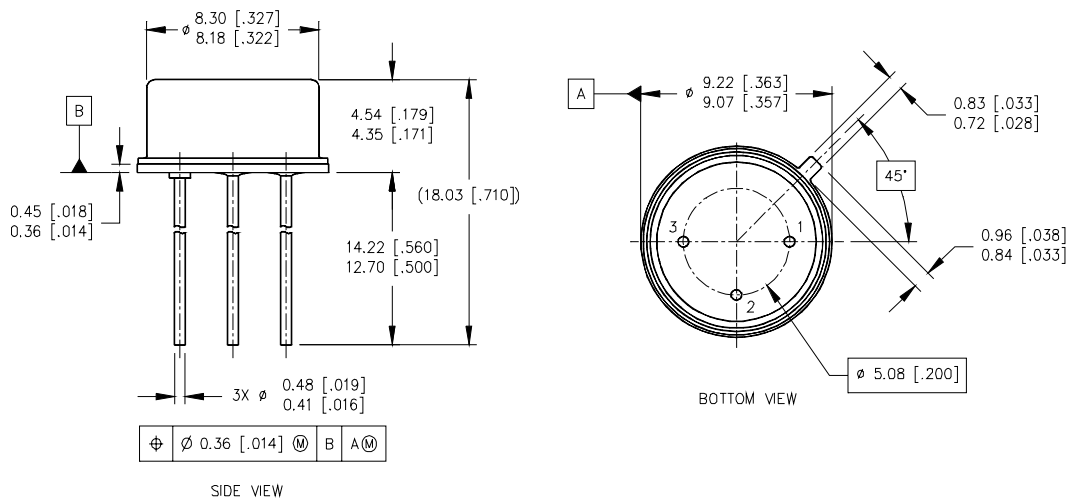


Fig 13b. Gate Charge Test Circuit

**Footnotes:**

- ① Repetitive Rating; Pulse width limited by maximum junction temperature.
- ②  $V_{DD} = 50V$ , Starting  $T_J = 25^\circ C$ ,  $L = 42.5mH$   
Peak  $I_L = 3.0A$ ,  $V_{GS} = 10V$ ,  $R_G = 25\Omega$
- ③  $I_{SD} \leq 3.0A$ ,  $di/dt \leq 90A/\mu s$ ,  
 $V_{DD} \leq 400V$ ,  $T_J \leq 150^\circ C$ , Suggested  $R_G = 7.5 \Omega$
- ④ Pulse width  $\leq 300 \mu s$ ; Duty Cycle  $\leq 2\%$

**Case Outline and Dimensions —TO-205AF (TO-39)**



NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME 14.5M-1994.
2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
3. CONTROLLING DIMENSION: INCH.
4. CONFORMS TO JEDEC OUTLINE TO-205AF (TO-39).

LEGEND

- 1- SOURCE
- 2- GATE
- 3- DRAIN